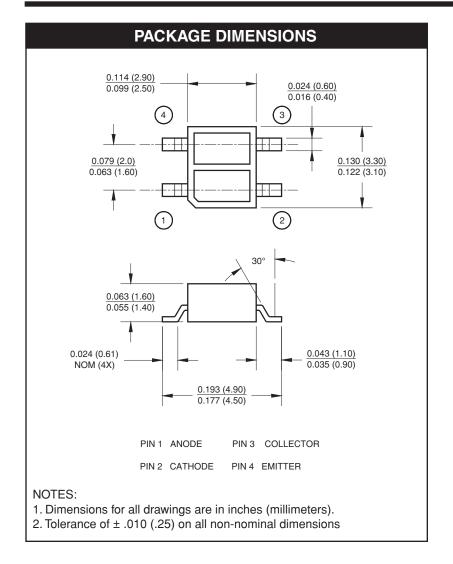
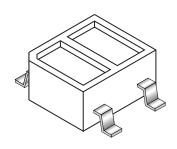
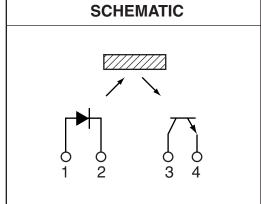
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FEATURES

- Phototransistor output
- · Tape and reel packaging
- No contact surface sensing
- Miniature package
- · Lead form style: Gull Wing



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Parameter	Symbol	Rating	Units °C	
Operating Temperature	T _{OPR}	-25 to +85		
Storage Temperature	T _{STG}	-30 to +100	°C	
Soldering Temperature (Iron) ^(2,3,4)	T _{SOL-I}	240 for 5 sec	°C	
Soldering Temperature (Flow) ^(2,3)	T _{SOL-F}	260 for 10 sec	°C	
EMITTER				
Continuous Forward Current	l _F	50	mA	
Reverse Voltage	V_{R}	5	V	
Peak Forward Current ⁽⁵⁾	I _{FP}	1	mA	
Power Dissipation ⁽¹⁾	P _D	75	mW	
SENSOR				
Collector-Emitter Voltage	V_{CEO}	30	V	
Emitter-Collector Voltage	V _{ECO}	5	V	
Collector Current	I _C	20	mA	
Power Dissipation ⁽¹⁾	P _D	50	mW	

ELECTRICAL / OPTICAL CHARACTERISTICS (T _A = 25°C unless otherwise specified)								
PARAMETER	TEST CONDITIONS	SYMBOL	MIN.	TYP.	MAX.	UNITS		
INPUT DIODE								
Forward Voltage	I _F = 20 mA	V_{F}	_	1.2	1.6	V		
Reverse Leakage Current	V _R = 5 V	I _R	_	_	10	μΑ		
Peak Emission Wavelength	I _F = 20 mA	λ _{PE}	_	940	_	nm		
OUTPUT TRANSISTOR								
Collector-Emitter Dark Current	$V_{CE} = 20 \text{ V}, I_{F} = 0 \text{ mA}$	I _D	_	_	100	nA		
COUPLED								
On-State Collector Current	$I_F = 20 \text{ mA}, V_{CE} = 5 \text{ V}$	I _{C(ON)}	0.15	0.40	_	mA		
Saturation Voltage		V _{CE (SAT)}	_	_	0.3	V		
Rise Time	V_{CC} = 5 V, $I_{C(ON)}$ = 100 μ A, R_L = 1 K Ω	t _r	_	20	_	μs		
Fall Time		t _f	_	20	_			

NOTES:

- 1. Derate power dissipation linearly 1.33 mW/°C above 25°C.
- 2. RMA flux is recommended.
- 3. Methanol or isopropyl alcohols are recommended as cleaning agents.
- 4. Soldering iron 1/16" (1.6mm) from housing.
- 5. Pulse conditions: $tp = 100 \mu s$; T = 10 ms.

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TYPICAL PERFORMANCE CURVES

Fig. 1 Normalized Collector Current vs. Distance between device and reflector

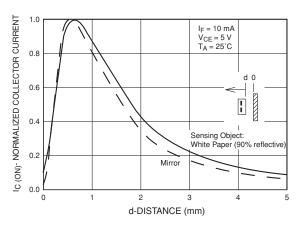


Fig. 3 Collector Current vs. Collector to Emitter Voltage

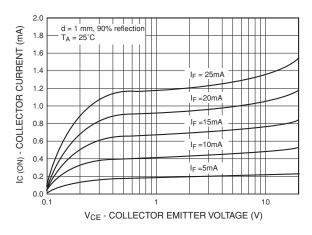


Fig. 2 Collector Current vs. Forward Current

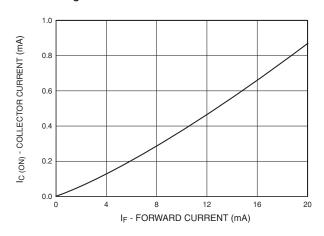
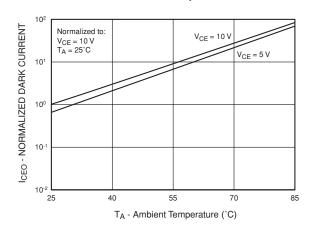


Fig. 4 Collector Emitter Dark Current (Normalized) vs. Ambient Temperature



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Fig. 5 Forward Current vs. Forward Voltage

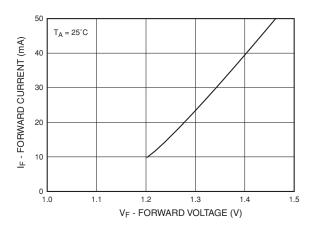


Fig. 6 Rise and Fall Time vs. Load Resistance

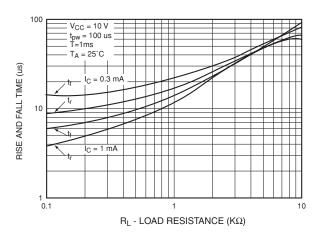
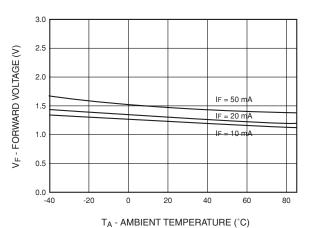


Fig. 7 Forward Voltage vs. Ambient Temperature





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